INTEGRATED CIRCUITS

DATA SHEET

SA5223

Wide dynamic range AGC transimpedance amplifier (150MHz)

Product specification IC19 Data Handbook

1995 Oct 24





Wide dynamic range AGC transimpedance amplifier(150MHz)

SA5223

DESCRIPTION

The SA5223 is a wide-band, low-noise transimpedance amplifier with differential outputs, incorporating AGC and optimized for signal recovery in wide-dynamic-range fiber optic receivers, such as SONET. The part is also suited for many other RF and fiber optic applications as a general purpose gain block.

The SA5223 is the first AGC amplifier to incorporate internal AGC loop hold capacitor, therefore, no external components are required. The internal AGC loop enables the SA5223 to effortlessly handle bursty data over a range of nA to mA of signal current, positive direction (sinking) only.

FEATURES

Extremely low noise: 1.17pA/√Hz

Single 5V supply

Low supply current: 22mALarge bandwidth: 150MHz

Differential outputs

Internal hold capacitor

Low input/output impedances

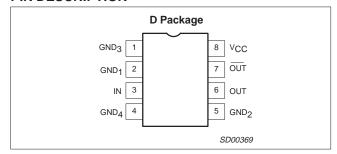
• High power-supply-rejection ratio: 55dB

Tight transresistance control

High input overload: 4mA

• 2000V HBM ESD protection

PIN DESCRIPTION



APPLICATIONS

- OC3 SONET preamp (see AN1431 for detailed analysis
- Current-to-voltage converters
- Wide-band gain block
- Medical and scientific instrumentation
- Sensor preamplifiers
- Single-ended to differential conversion
- Low noise RF amplifiers
- RF signal processing

ORDERING INFORMATION

DESCRIPTION	TEMPERATURE RANGE	ORDER CODE	DWG #
8-Pin Plastic Small Outline	-40 to +85°C	SA5223D	SOT96-1

For unpackaged die please contact factory.

ABSOLUTE MAXIMUM RATINGS

SYMBOL	PARAMETER	RATING	UNITS
V _{CC}	Power supply voltage	6	V
T _A	Ambient temperature range	-40 to +85	°C
TJ	Junction temperature range	-55 to +150	°C
T _{STG}	Storage temperature range	-65 to +150	°C
P_{D}	Power dissipation T _A = 25°C (still air) ¹	0.78	W
I _{INMAX}	Maximum input current	5	mA

NOTE

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	RATING	UNITS
V _{CC}	Power supply voltage	4.5 to 5.5	V
T _A	Ambient temperature range: SA grade	-40 to +85	°C
T_J	Junction temperature range: SA grade	-40 to +105	°C

^{1.} Maximum power dissipation is determined by the operating ambient temperature and the thermal resistance $\theta_{JA} = 158^{\circ}$ C/W. Derate 6.2mW/°C above 25°C.

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DC ELECTRICAL CHARACTERISTICS

Typical data and Min and Max limits apply at $T_A = 25$ °C, and $V_{CC} = +5V$, unless otherwise specified.

CVMPOL	PARAMETER	TEST CONDITIONS		UNIT		
SYMBOL PARA	PARAMETER	:R TEST CONDITIONS	Min	Тур	Max	UNII
V _{IN}	Input bias voltage		1.3	1.55	1.8	V
V _{O±}	Output bias voltage		2.9	3.2	3.5	V
Vos	Output offset voltage (V _{PIN6} - V _{PIN7})		-200	80	+200	mV
Icc	Supply current		15	22	29	mA
I _{OMAX}	Output sink/source current		1.5	2		mA

NOTE: Standard deviations are estimated from design simulations to represent manufacturing variations over the life of the product.

AC ELECTRICAL CHARACTERISTICS

Typical data and Min and Max limits apply at $T_A = 25^{\circ}C$ and $V_{CC} = +5V$, unless otherwise specified.

OVALDOL	24244555	TEGT COMPLETIONS				
SYMBOL	PARAMETER	TEST CONDITIONS	Min	Тур	Max	UNIT
R _T	Transresistance (differential output)	90	125	160	kΩ	
R _T	Transresistance (single-ended output)	45	62.5	80	kΩ	
R _O	Output resistance (differential output)	DC tested		140		Ω
R _O	Output resistance (single-ended output)	DC tested		70		Ω
f _{3dB}	Bandwidth (-3dB)	Test Circuit 1	110	150		MHz
R _{IN}	Input resistance	DC tested		250		Ω
C _{IN}	Input capacitance ¹			0.7		pF
C _{INT}	Input capacitance including Miller multiplied capacitance			4.0		pF
ΔR/ΔV	Transresistance power supply sensitivity	$V_{CC1} = V_{CC2} = 5 \pm 0.5V$		3		%/V
ΔR/ΔΤ	Transresistance ambient temperature sensitivity	$\Delta T_A = T_{A MAX} - T_{A MIN}$		0.09		%/ºC
I _{IN}	RMS noise current spectral density (referred to input) ²	Test Circuit 2, f = 10MHz		1.17		pA/√Hz
	Integrated RMS noise current over the band-	Test circuit 2, $\Delta f = 50MHz$		7		
	width (referred to input) C _S = 0.1pF	$\Delta f = 100MHz$		12		1
Ι _Τ	05 = 0.1.p.	$\Delta f = 150MHz$		16		nA
· .		$\Delta f = 50MHz$		8		1
	C _S = 0.4pF	$\Delta f = 100MHz$		13		1
		$\Delta f = 150MHz$		18		1
PSRR	Power supply rejection ratio (change in V _{OS})	DC Tested, $\Delta V_{CC} = \pm 0.5V$		-55		dB
PSRR	Power supply rejection ratio ³	f = 1.0MHz, Test Circuit 3		-20		dB
V_{OLMAX}	Maximum differential output AC voltage	I _i = 0-2mA peak AC		800		mV
$\frac{dR_T}{dt}$	AGC loop time constant parameter ⁴	10μA to 20μA steps		1		dB/ms
I _{INMAX}	Maximum input amplitude for output duty cycle of 50 ±5% Test circuit 4			+2		mA
t _r , t _f	Output rise and fall times	Output rise and fall times 10 – 90%				
t _D	Group delay	f = 10MHz		2.2		ns

NOTES:

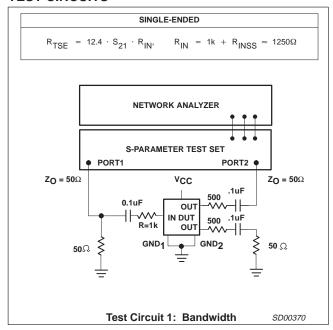
- 1. Does not include Miller-multiplied capacitance of input device.
- 2. Noise performance measured differential. Single-ended output noise is higher due to CM noise.
- PSRR is output referenced and is circuit board layout dependent at higher frequencies. For best performance use a RF filter in V_{CC} line.
 This implies that the SA5223 gain will change 1dB (10%) in the absence of data for 1ms (i.e., can handle bursty data without degrading Bit Error Rate (BER) for 100,000 cycles at 100MHz).

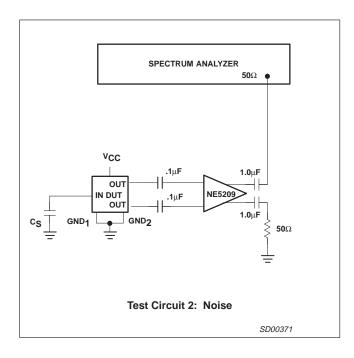
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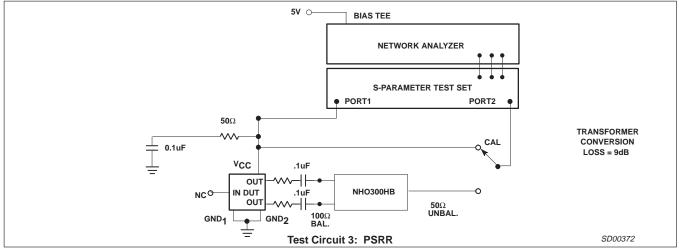
Wide dynamic range AGC transimpedance amplifier(150MHz)

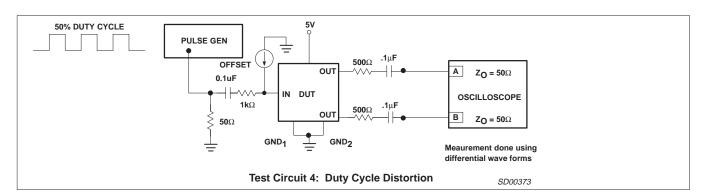
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TEST CIRCUITS









Wide dynamic range AGC transimpedance amplifier(150MHz)

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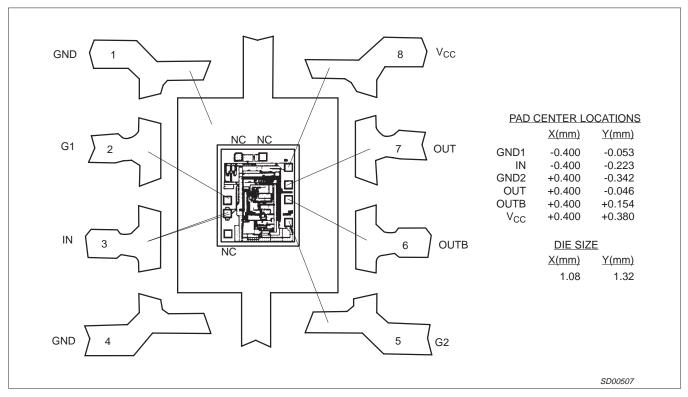


Figure 1. SA5223 Bonding Diagram

Die Sales Disclaimer

Due to the limitations in testing high frequency and other parameters at the die level, and the fact that die electrical characteristics may shift after packaging, die electrical parameters are not specified and die are not guaranteed to meet electrical characteristics (including temperature range) as noted in this data sheet which is intended only to specify electrical characteristics for a packaged device.

All die are 100% functional with various parametrics tested at the wafer level, at room temperature only (25°C), and are guaranteed to be 100% functional as a result of electrical testing to the point of wafer sawing only. Although the most modern processes are utilized for wafer sawing and die pick and place into waffle pack

carriers, it is impossible to guarantee 100% functionality through this process. There is no post waffle pack testing performed on individual die.

Since Philips Semiconductors has no control of third party procedures in the handling or packaging of die, Philips Semiconductors assumes no liability for device functionality or performance of the die or systems on any die sales.

Although Philips Semiconductors typically realizes a yield of 85% after assembling die into their respective packages, with care customers should achieve a similar yield. However, for the reasons stated above, Philips Semiconductors cannot guarantee this or any other yield on any die sales.

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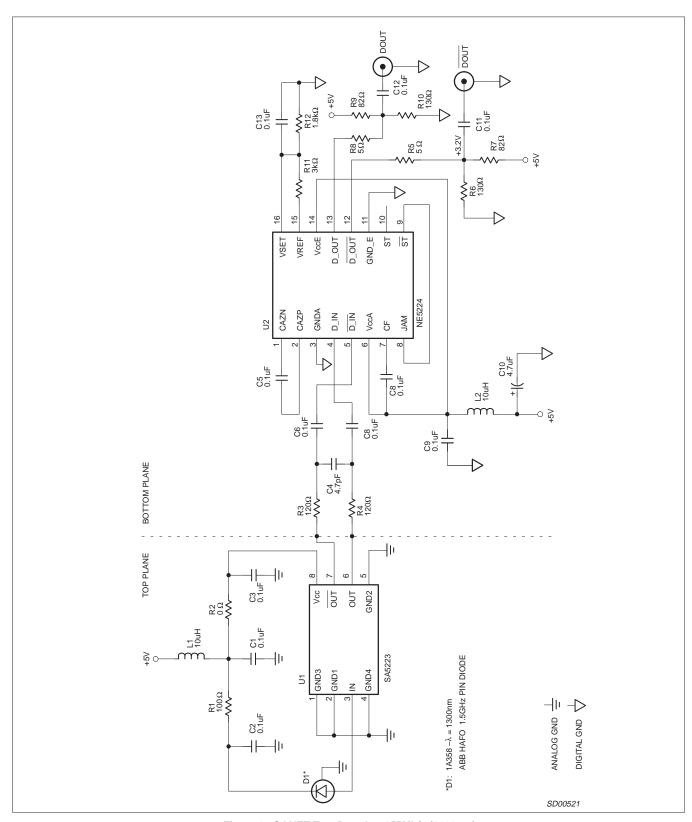


Figure 2. SONET Test Board — 155Mb/s (1300nm)

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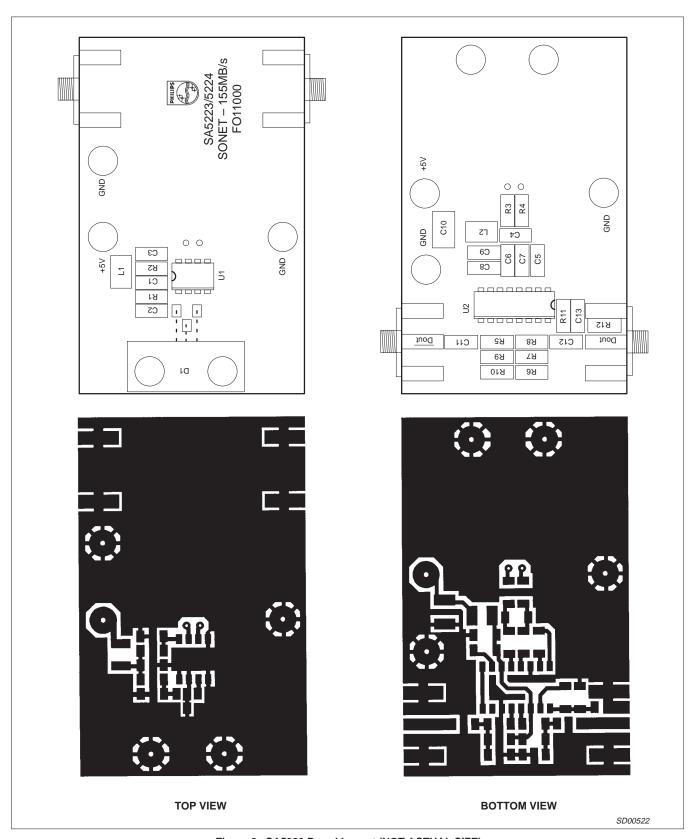


Figure 3. SA5223 Board Layout (NOT ACTUAL SIZE)

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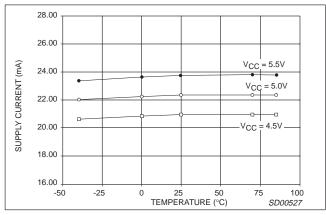


Figure 4. SA5223 I_{CC} vs Temperature

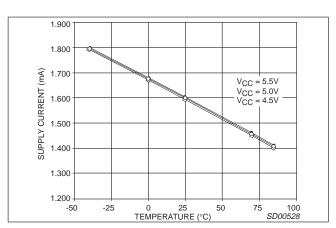


Figure 5. SA5223 Input $V_{\mbox{\footnotesize BIAS}}$ vs Temperature

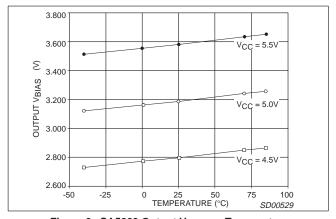


Figure 6. SA5223 Output $V_{\mbox{\footnotesize BIAS}}$ vs Temperature

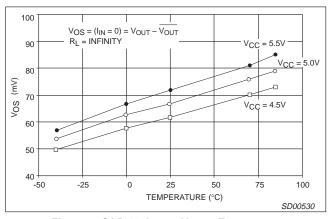


Figure 7. SA5223 Output V_{OS} vs Temperature

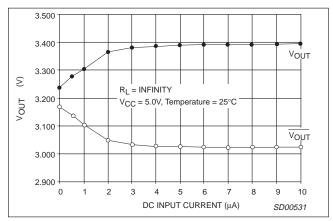


Figure 8. SA5223 Output Voltage vs DC Input Current (for small input current)

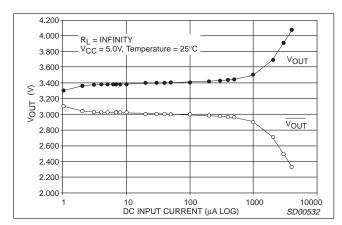


Figure 9. SA5223 Output Voltage vs DC Input Current (for large input current)

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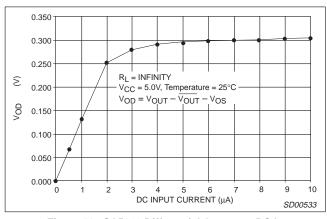


Figure 10. SA5223 Differential Output vs DC I_{IN} (for small input current)

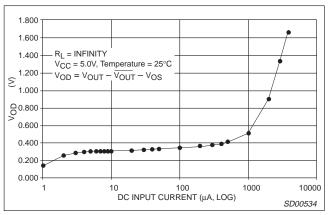


Figure 11. SA5223 Differential Output vs DC I_{IN}

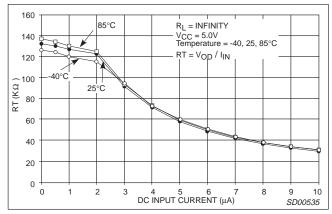


Figure 12. SA5223 Differential RT vs DC I_{IN} (for small input current)

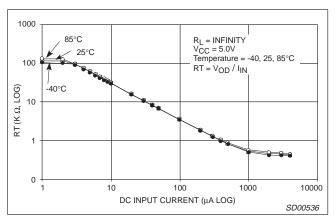


Figure 13. SA5223 Differential RT vs DC I_{IN} (for large input current)

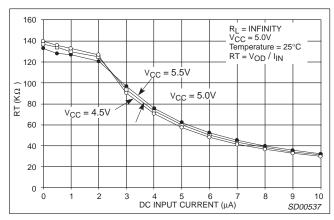


Figure 14. SA5223 Differential RT vs DC I_{IN} (for small input current)

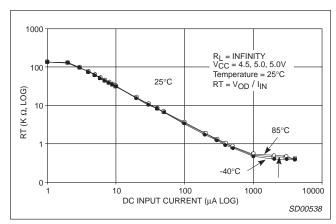


Figure 15. SA5223 Differential RT vs DC I_{IN} (for large input current)

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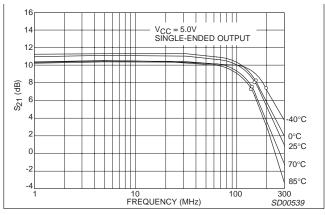


Figure 16. Insertion Gain vs Frequency

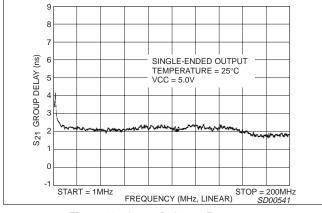


Figure 18. Group Delay vs Frequency

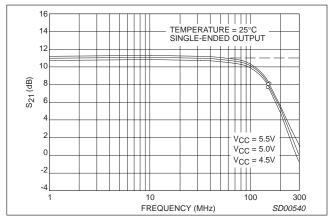


Figure 17. Insertion Gain vs Frequency

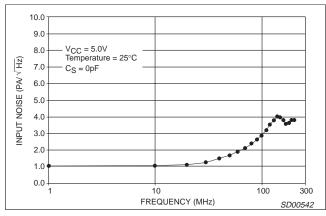


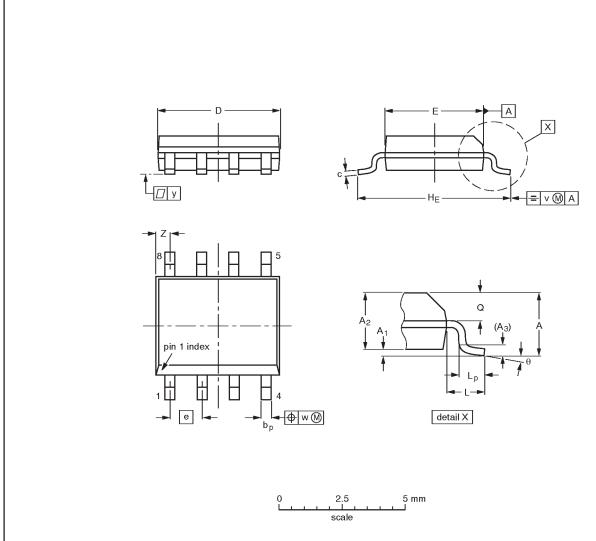
Figure 19. SA5223 Input Current RMS Noise Spectral Density

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SO8: plastic small outline package; 8 leads; body width 3.9mm

SOT96-1



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A ₁	A ₂	А3	bp	С	D ⁽¹⁾	E ⁽²⁾	е	HE	L	Lp	Q	v	w	у	Z ⁽¹⁾	θ
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	5.0 4.8	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8°
inches	0.069	0.0098 0.0039		0.01		0.0098 0.0075	0.20 0.19	0.16 0.15	0.050	0.24 0.23	0.041	0.039 0.016	0.028 0.024	0.01	0.01	0.004	0.028 0.012	0°

Notes

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	RENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE
SOT96-1	076E03S	MS-012AA			92-11-17 95-02-04

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Data sheet status

Data sheet status	Product status	Definition [1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
Preliminary specification	Qualification	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make chages at any time without notice in order to improve design and supply the best possible product.
Product specification	Production	This data sheet contains final specifications. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.

^[1] Please consult the most recently issued datasheet before initiating or completing a design.

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